

900V GaN Power Transistor (FET)

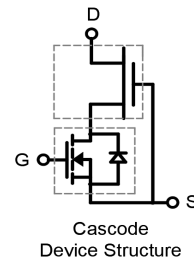
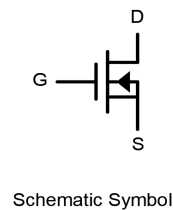
Features

- Easy to use, compatible with standard gate drivers
- Excellent $Q_G \times R_{DS(on)}$ figure of merit (FOM)
- Low Q_{RR} , no free-wheeling diode required
- Low switching loss
- RoHS compliant and Halogen-free

Product Summary		
V_{DSS}	900	V
$R_{DS(on), typ}$	150	mΩ
$Q_{G, typ}$	21	nC
$Q_{RR, typ}$	26	nC

Applications

- High efficiency power supplies
- Telecom and datacom
- Automotive
- Servo motors



Packaging

Part Number	Package	Packaging	Base QTY
RX90T150PS2A	3 Lead TO-220	Tube	50

Maximum ratings, at $T_C=25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter		Limit Value	Unit
I_D	Continuous drain current @ $T_C=25^\circ\text{C}$		17	A
	Continuous drain current @ $T_C=100^\circ\text{C}$		11	A
I_{DM}	Pulsed drain current @ $T_C=25^\circ\text{C}$ (pulse width: 10us)		75	A
	Pulsed drain current @ $T_C=150^\circ\text{C}$ (pulse width: 10us)		55	A
V_{DSS}	Drain to source voltage ($T_J = -55^\circ\text{C}$ to 150°C)		900	V
V_{TDSS}	Transient drain to source voltage ^a		1000	V
V_{GSS}	Gate to source voltage		± 20	V
P_D	Maximum power dissipation @ $T_C=25^\circ\text{C}$		74	W
T_C	Operating temperature	Case	-55 to 150	$^\circ\text{C}$
T_J		Junction	-55 to 150	$^\circ\text{C}$
T_S	Storage temperature		-55 to 150	$^\circ\text{C}$
T_{CSOLD}	Soldering peak temperature		260	$^\circ\text{C}$

Thermal Resistance

Symbol	Parameter	Typical	Unit
R _{θJC}	Junction-to-case	1.7	°C/W
R _{θJA}	Junction-to-ambient ^b	50	°C/W

Notes:

- Off-state spike duty cycle < 0.01, spike duration < 2μs
- Device on one layer epoxy PCB for drain connection (vertical and without air stream cooling, with 6cm² copper area and 70μm thickness)

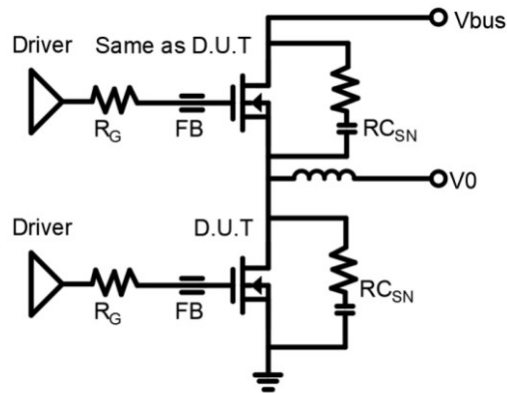
Electrical Parameters, at $T_J=25^\circ\text{C}$, unless otherwise specified

Symbol	Min	Typ	Max	Unit	Test Conditions
Forward Characteristics					
V _{DSS-MAX}	900	-	-	V	V _{GS} =0V
BV _{DSS}		1500			V _{GS} =0V, I _{DSS} =250μA
V _{GS(th)}	3	4	5	V	V _{DS} =V _{GS} , I _D =500μA
R _{DS(on)} ^c	-	150	190	mΩ	V _{GS} =8V, I _D =4A, T _J =25°C
	-	300	-		V _{GS} =8V, I _D =4A, T _J =150°C
I _{DSS}	-	5	20	μA	V _{DS} =900V, V _{GS} =0V, T _J =25°C
	-	50	-	μA	V _{DS} =900V, V _{GS} =0V, T _J =150°C
I _{GSS}	-	-	150	nA	V _{GS} =20V
	-	-	-150	nA	V _{GS} =-20V
C _{ISS}	-	624	-	pF	V _{GS} =0V, V _{DS} =600V, f=1MHz
C _{OSS}	-	40	-	pF	
C _{RSS}	-	4	-	pF	
C _{O(er)}	-	52	-	pF	V _{GS} =0V, V _{DS} =0 - 600V
C _{O(tr)}	-	95	-	pF	
Q _G	-	21	-	nC	V _{DS} =600V, V _{GS} =0 -12V, I _D =10A
Q _{GS}	-	6.7	-		
Q _{GD}	-	5	-		
t _{D(on)}	-	44	-	ns	V _{DS} =600V, V _{GS} =0 - 12V, I _D =10A, R _G =40Ω
t _R	-	16	-		
t _{D(off)}	-	40	-		
t _F	-	12	-		
Reverse Characteristics					
V _{SD}	-	1.3	-	V	V _{GS} =0V, I _S =2A, T _J =25°C
	-	1.9	-		V _{GS} =0V, I _S =5A, T _J =25°C
	-	3	-		V _{GS} =0V, I _S =5A, T _J =150°C
t _{RR}	-	16	-	ns	I _S =10A, V _{GS} =0V, d _I /d _t =1000A/us, V _{DD} =600V
Q _{RR}	-	26	-	nC	

Notes:

C. Dynamic on-resistance; see Figure 17 and 18 for test circuit and configurations

Circuit Implementation



Recommended Single Ended Drive Circuit

Recommended gate drive: (0 V, 12 V) with $R_{G(tot)} = 41 \Omega$, where $R_{G(tot)} = R_G + R_{driver}$

Gate Ferrite Bead (FB)	Gate Resistance1 (R_G)	RC Snubber (RC_{SN})
MPZ1608S471ATA00	40 Ω	69 pF + 15 Ω

Notes:

- d. RC_{sn} should be placed as close as possible to the drain pin
- e. The layout and wiring of the drive circuit should be as short as possible

Typical Characteristics, at $T_C=25^\circ\text{C}$, unless otherwise specified

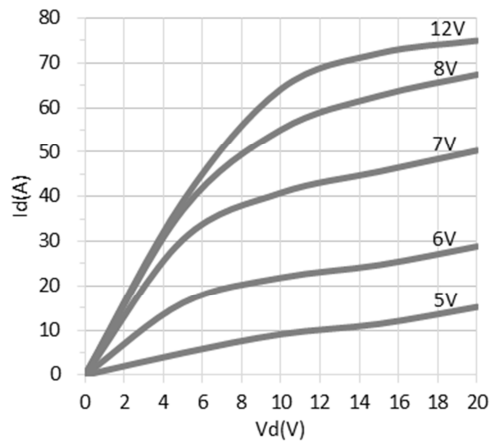


Figure 1. Typical Output Characteristics $T_j=25^\circ\text{C}$

Parameter: V_{GS}

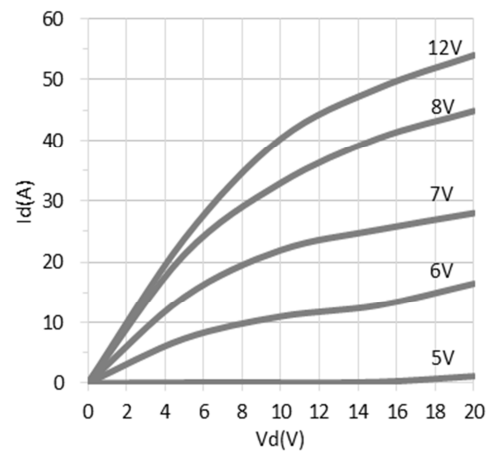


Figure 2. Typical Output Characteristics $T_j=150^\circ\text{C}$

Parameter: V_{GS}

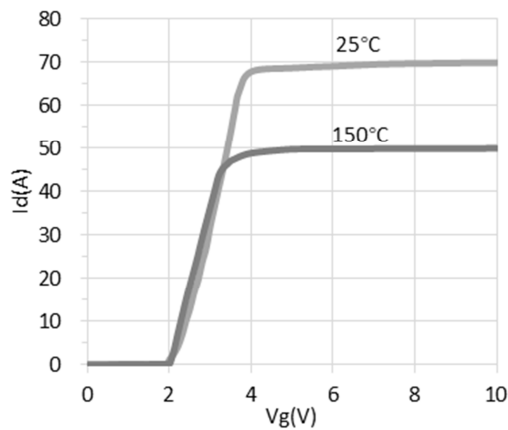


Figure 3. Typical Transfer Characteristics

$V_{DS}=10\text{V}$, Parameter: T_j

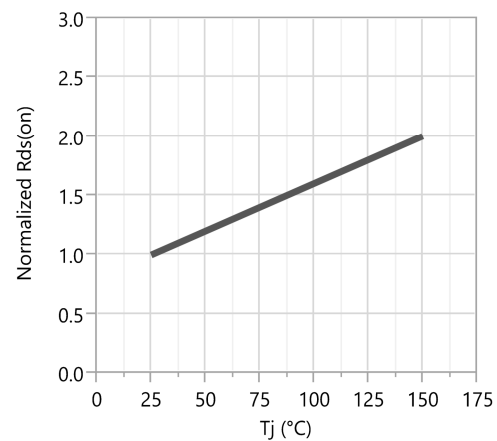


Figure 4. Normalized On-resistance

$I_D=4\text{A}$, $V_{GS}=8\text{V}$

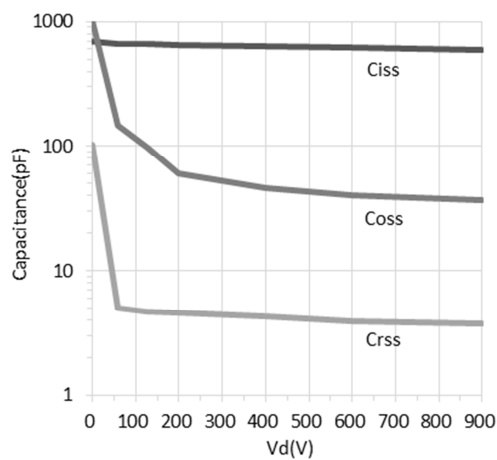


Figure 5. Typical Capacitance

$V_{GS}=0\text{V}$, $f=1\text{MHz}$

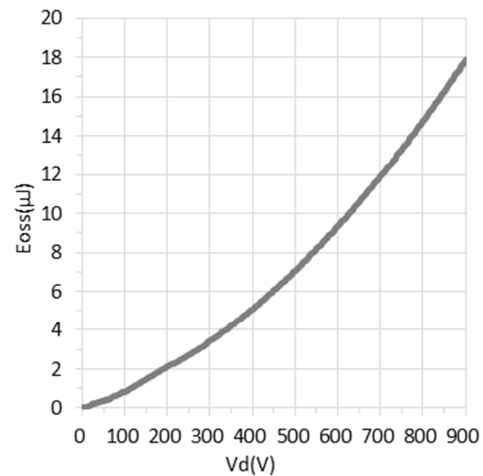


Figure 6. Typical C_{OSS} Stored Energy

Typical Characteristics, at $T_c=25^\circ\text{C}$, unless otherwise specified

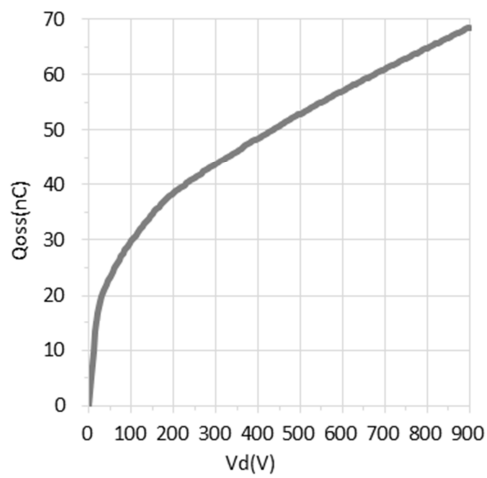


Figure 7. Typical Qoss

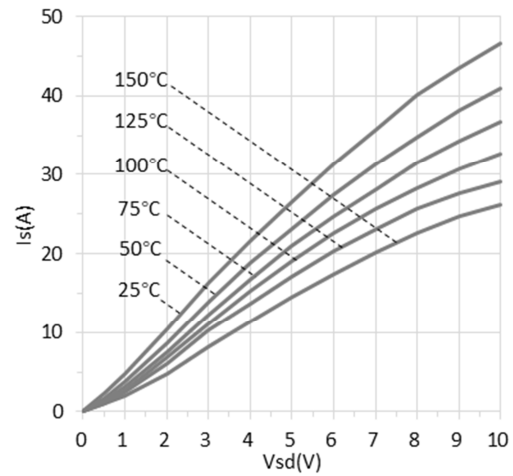


Figure 8. Forward Characteristic of Rev. Diode

$I_s=f(V_s)$, Parameter T_j

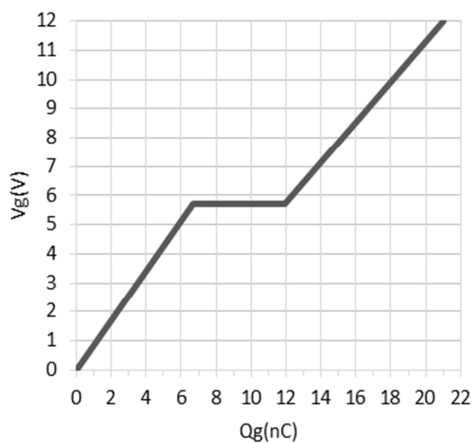


Figure 9. Typical Gate Charge

$I_{DS}=5.5\text{A}$, $V_{DS}=400\text{V}$

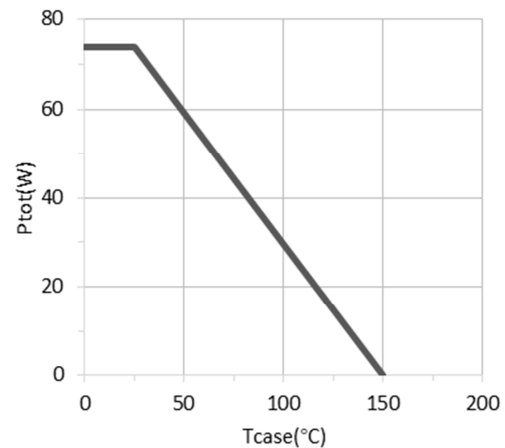


Figure 10. Power Dissipation

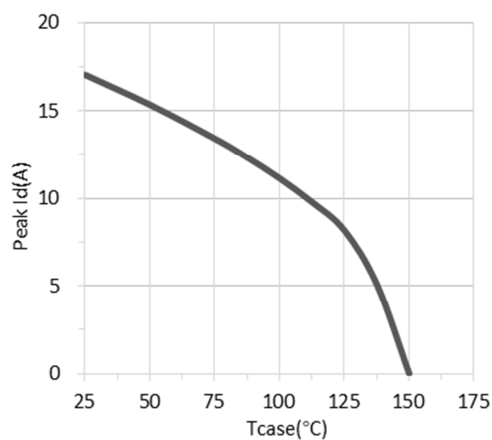


Figure 11. Current Derating

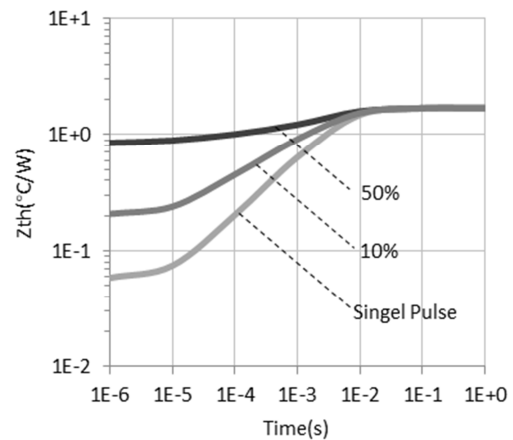


Figure 12. Transient Thermal Resistance

Typical Characteristics, at $T_c=25\text{ }^{\circ}\text{C}$, unless otherwise specified

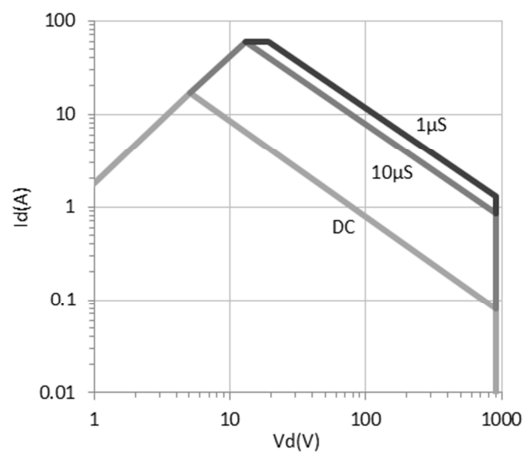


Figure 13. Safe operating Area $T_c=25\text{ }^{\circ}\text{C}$
(calculated based on thermal limit)

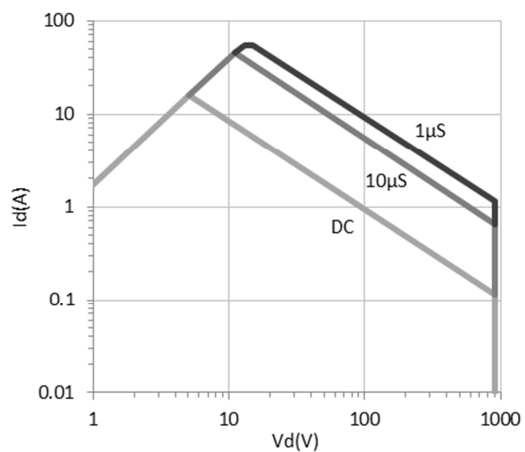


Figure 14. Safe operating Area $T_c=80\text{ }^{\circ}\text{C}$
(calculated based on thermal limit)

Test Circuits and Waveforms

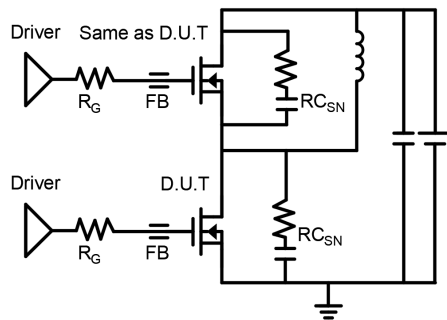


Figure 15. Switching Time Test Circuit

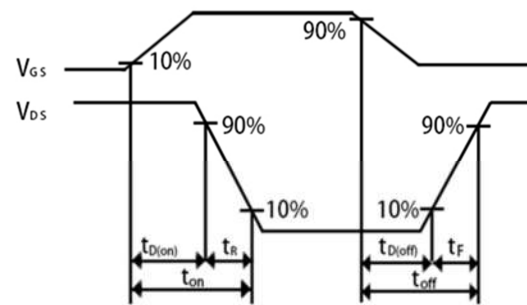


Figure 16. Switching Time Waveform

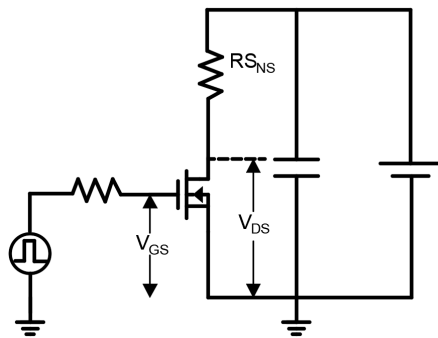


Figure 17. Dynamic $R_{DS(on)eff}$ Test Circuit

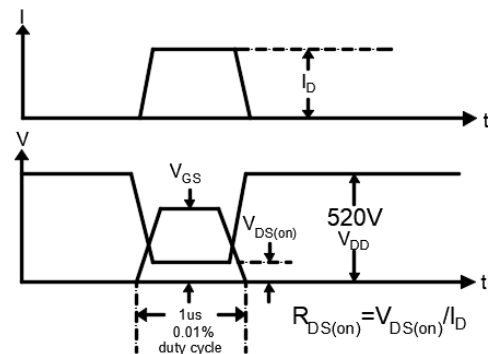


Figure 18. Dynamic $R_{DS(on)eff}$ Waveform

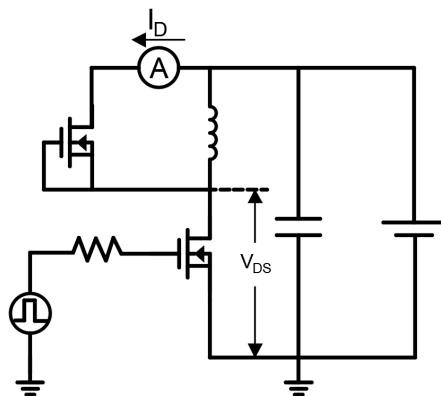


Figure 19. Diode Characteristic Test Circuits

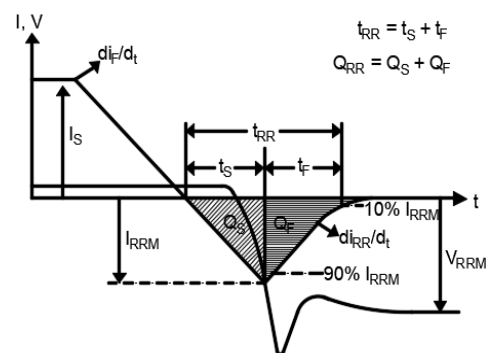


Figure 20. Diode Recovery Waveform

Design Considerations

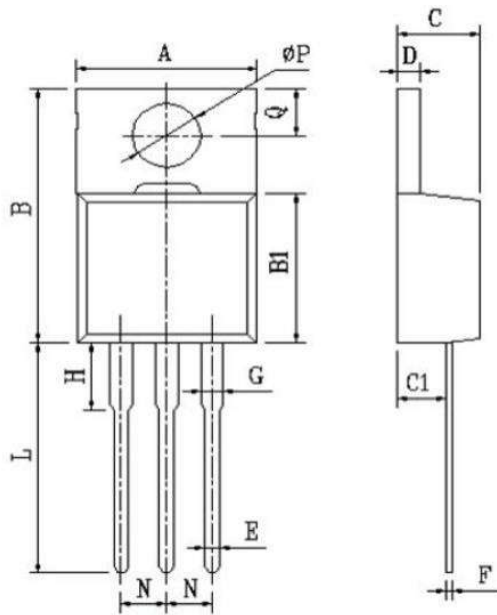
Fast switching GaN device can reduce power conversion losses, and thus enable high frequency operations. Certain PCB design rules and instructions, however, need to be followed to take full advantages of fast switching GaN devices.

Before evaluating Runxin Micro's GaN devices, please refer to the table below which provides some practical rules that should be followed during the evaluation.

When Evaluating Runxin Micro's GaN Devices:

DO	DO NOT
Make sure the traces are as short as possible for both drive and power loops to minimize parasitic inductance	Using Runxin Micro's devices in GDS board layouts
Use the test tool with the shortest inductive loop, and make sure test points should be placed close enough	Use differential mode probe or probe ground clip with long wires
Minimize the lead length of TO packages when installing them to PCB	Use long traces in drive circuit, or long lead length of the devices

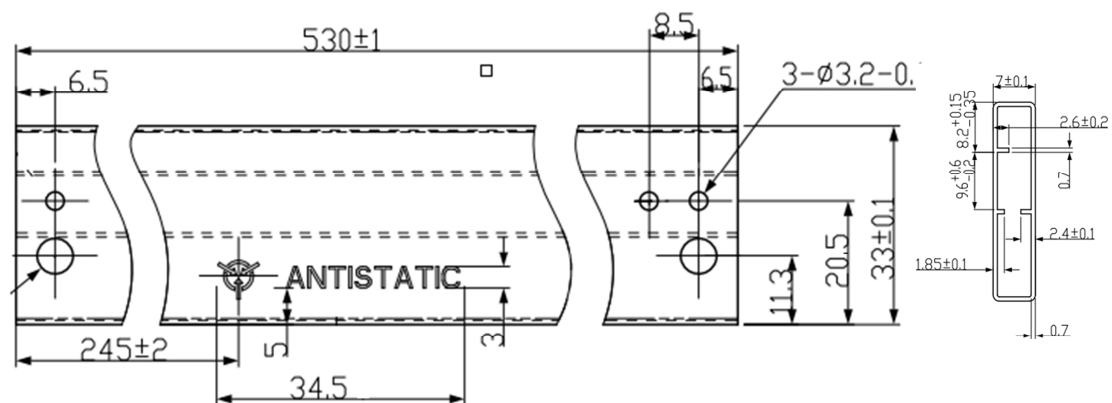
Package Outline



SYMBOL	COMMON DIMENSIONS	
	MM	
	MIN	MAX
A	10.1	10.5
B	15.2	15.6
B1	9.00	9.40
C	4.40	4.60
C1	2.40	3.00
D	1.20	1.40
E	0.70	0.90
F	0.30	0.50
G	1.17	1.37
H	3.30	3.80
L	13.1	13.7
N	2.34	2.74
Q	2.40	3.00
ΦP	3.70	3.90

Tube Information

Dimensions are shown in millimeters



Revision History

Version	Date	Change(s)
1.0	06/22/2022	Release formal datasheet
1.1	10/27/2022	Revise $C_{O(er)}$, $C_{O(tr)}$, Q_G , Q_{GS} , Q_{GD}
1.2	02/16/2023	Revise BV_{DSS} , Revise I_D
1.3	03/10/2023	Revise Package Outline
1.4	08/09/2023	Revise R_{jc} , I_D , PD, Ciss, Coss, Crss, $C_{O(er)}$, $C_{O(tr)}$, SOA